

Vishay Siliconix

RoHS

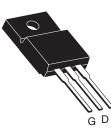
COMPLIANT

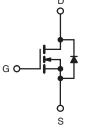
Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	600			
R _{DS(on)} (Ω)	V _{GS} = 10 V	2.2		
Q _g (Max.) (nC)	31			
Q _{gs} (nC)	4.6			
Q _{gd} (nC)	17			
Configuration	Single			

S

TO-220 FULLPAK





N-Channel MOSFET

FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFIBC30GPbF
	SiHFIBC30G-E3
SnPb	IRFIBC30G
	SiHFIBC30G

ABSOLUTE MAXIMUM RATINGS $T_C = 25 \text{ °C}$, unless otherwise noted							
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-Source Voltage			V _{DS}	600	V		
Gate-Source Voltage			V _{GS}	± 20	v		
Continuous Drain Current	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$	I _D -	2.5			
	V _{GS} at 10 V	$T_C = 100 ^{\circ}C$		1.6	А		
Pulsed Drain Current ^a			I _{DM}	10			
Linear Derating Factor				0.28	W/°C		
Single Pulse Avalanche Energy ^b			E _{AS}	250	mJ		
Repetitive Avalanche Current ^a			I _{AR}	2.5	A		
Repetitive Avalanche Energy ^a			E _{AR}	3.5	mJ		
Maximum Power Dissipation	T _C = 25 °C		P _D 35		W		
Peak Diode Recovery dV/dt ^c			dV/dt	3.0	V/ns		
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for	for 10 s 300 ^d		300 ^d			
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in		
				1.1	N · m		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 73 mH, $R_G = 25 \Omega$, $I_{AS} = 2.5 \text{ A}$ (see fig. 12).

c. $I_{SD} \leq 3.6$ A, $dI/dt \leq 60$ A/µs, $V_{DD} \leq V_{DS}, \, T_J \leq 150 \ ^{\circ}C.$

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

Vishay Siliconix



PARAMETER Maximum Junction-to-Ambient Maximum Junction-to-Case (Drain) SPECIFICATIONS T _J = 25 °C, 1	SYMBOL R _{thJA} R _{thJC}	ТҮР -		MAX.			UNIT	
Maximum Junction-to-Case (Drain)		-				UNIT		
· · · /	R _{thJC}		- 65			0000		
SPECIFICATIONS T - 25 °C		- 3.6			°C/W			
SPECIFICATIONS 1 - 25 °C		· · · · · · · · · · · · · · · · · · ·						
						T \/D		
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static			0.1/1 0	50	000		[
Drain-Source Breakdown Voltage	V _{DS}		$= 0 V, I_D = 2$	-	600	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$		e to 25 °C,		-	0.62	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$			2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 600 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	100	μA	
			1	, T _J = 125 °C	-	-	500	<u> </u>
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	5	= 1.5 A ^b	-	-	2.2	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D =	1.5 A ^b	2.2	-	-	S
Dynamic		1				1		1
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5		-	660	-	рF	
Output Capacitance	C _{oss}			-	86	-		
Reverse Transfer Capacitance	C _{rss}			-	19	-		
Drain to Sink Capacitance	С		f = 1.0 MHz	2	-	12	-	
Total Gate Charge	Qg			-	-	31		
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$		6 A, V _{DS} = 360 V, e fig. 6 and 13 ^b	-	-	4.6	nC
Gate-Drain Charge	Q _{gd}				-	-	17	
Turn-On Delay Time	t _{d(on)}				-	11	-	
Rise Time	t _r	$\label{eq:VDD} \begin{array}{l} V_{DD} = 300 \ V, \ I_D = 3.6 \ A, \\ R_G = 12 \ \Omega, \ R_D = 82 \ \Omega, \\ \text{see fig. } 10^b \end{array}$			-	13	-	
Turn-Off Delay Time	t _{d(off)}			-	35	-	ns	
Fall Time	t _f			-	14	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-		
Internal Source Inductance	L _S			-	7.5	-	nH	
Drain-Source Body Diode Characteristic	s	•						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.5	А	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	10		
Body Diode Voltage	V _{SD}	$T_J = 25 \ ^\circ C, \ I_S = 2.5 \ A, \ V_{GS} = 0 \ V^b$		-	-	1.6	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \ ^{\circ}C, I_F = 3.6 \ A, dI/dt = 100 \ A/\mu s^b$		dt - 100 A/usb	-	400	810	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.1	4.2	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L					_D)	

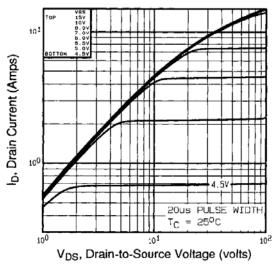
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.

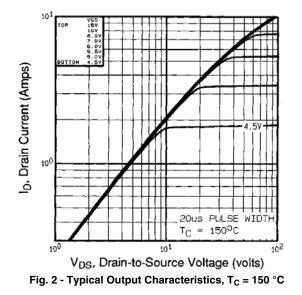


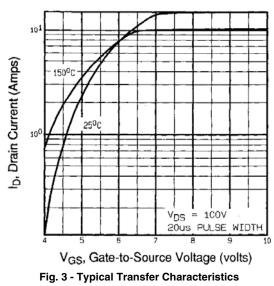
Vishay Siliconix

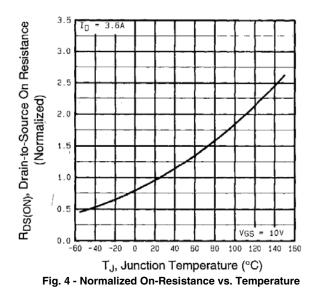


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted









Vishay Siliconix



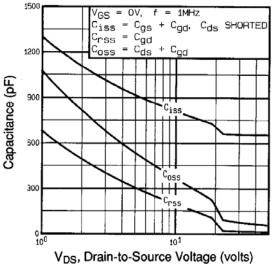


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

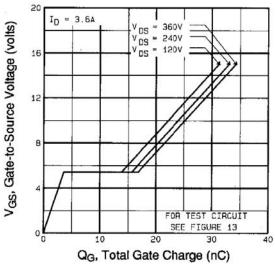


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

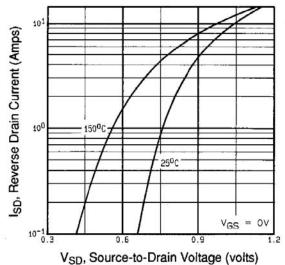
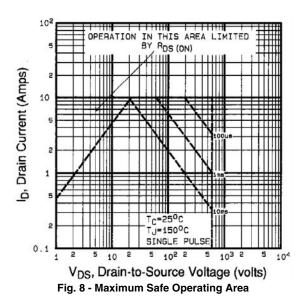


Fig. 7 - Typical Source-Drain Diode Forward Voltage





Vishay Siliconix

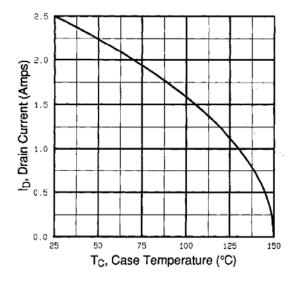


Fig. 9 - Maximum Drain Current vs. Case Temperature

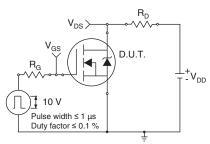


Fig. 10a - Switching Time Test Circuit

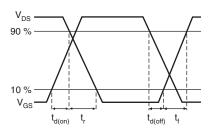


Fig. 10b - Switching Time Waveforms

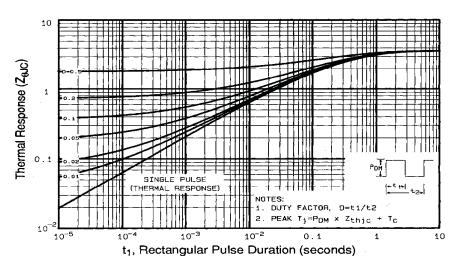


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

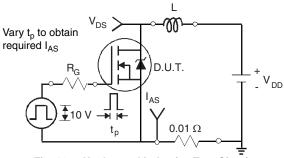


Fig. 12a - Unclamped Inductive Test Circuit

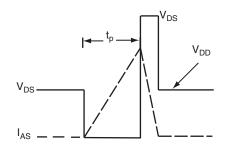


Fig. 12b - Unclamped Inductive Waveforms

Vishay Siliconix



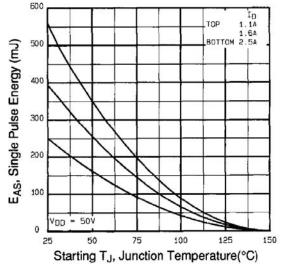


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

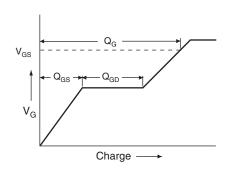


Fig. 13a - Basic Gate Charge Waveform

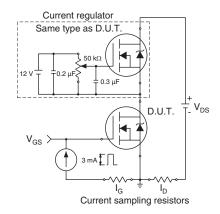
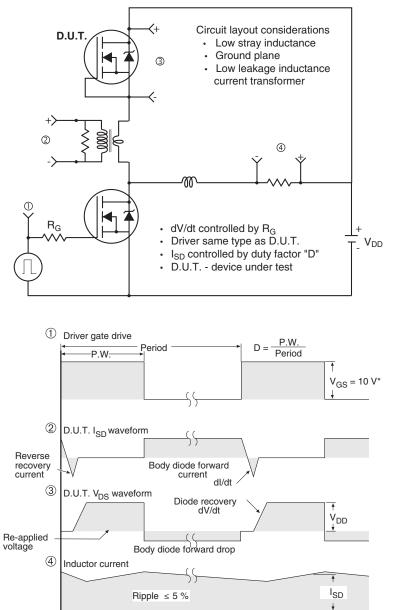


Fig. 13b - Gate Charge Test Circuit



Vishay Siliconix



Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?91180.



Vishay

Disclaimer

All product specifications and data are subject to change without notice.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

Vishay disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless otherwise expressly indicated. Customers using or selling Vishay products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Vishay for any damages arising or resulting from such use or sale. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

Product names and markings noted herein may be trademarks of their respective owners.